

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

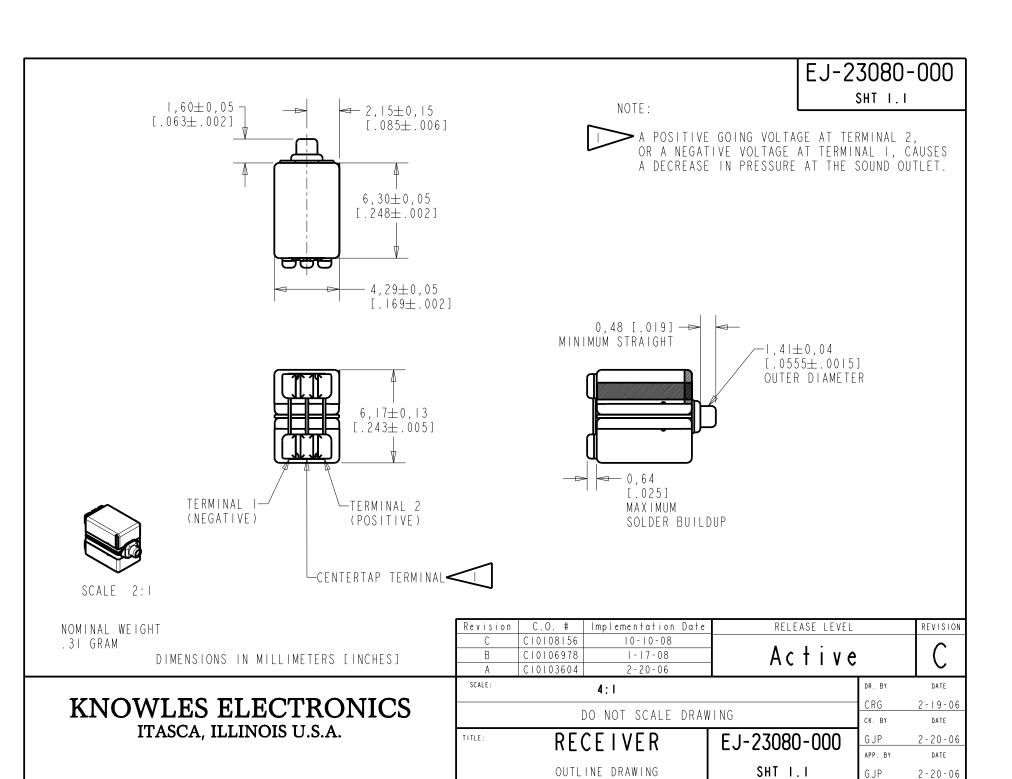
Email & Skype: info@chipsmall.com Web: www.chipsmall.com

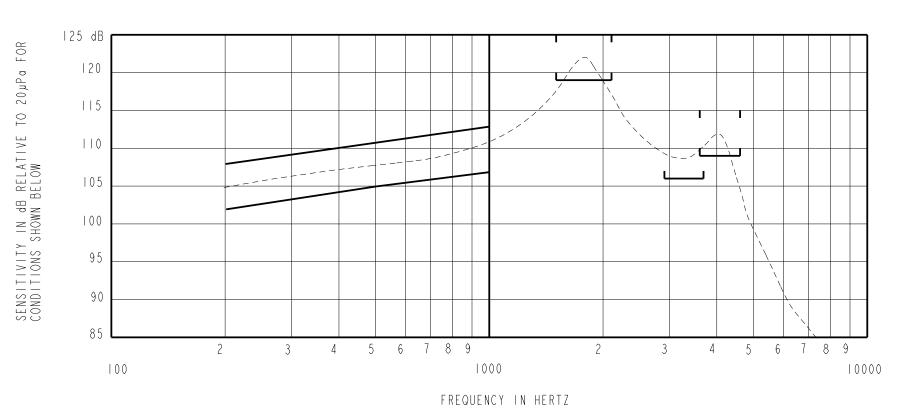
Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China











NOTES:

I. MEASUREMENTS MADE USING 10m (.394") X 1mm (.039") ID TUBE CONNECTED TO A SIMULATED ANSI S3.7-1973 TYPE HA-3 COUPLER. (IEC 126).

2.		SENSI	SENSITIVITY		
FREQU	JE NC Y	<u> </u>	ИIN.	MAX.	
	200	1	02.0	108.0	
	500		05.0	111.0	
	1000	[]	07.0	113.0	
1500-	2100		19.0	125.0	
2900-	3700	[1	06.0		
3600-			09.0	115.0	

- 3. RESPONSE, IMPEDANCE, AND DISTORTION MEASUREMENTS MADE USING THE ELECTRICAL TEST CONDITIONS SHOWN BELOW.
- 4. ELECTRICAL SOURCE IMPEDANCE MUST BE GREATER THAN 20 TIMES IKHZ IMPEDANCE FOR TEST CONDITIONS SHOWN BELOW.
- 5. INDIVIDUAL SPECIFICATIONS.

PORT LOCATION	IMPEDANCE OHMS ±15%		DCR @20°C	DISTORTION		ELECTRICAL TEST CONDITIONS		
	LOCATION	IKHz	500Hz	OHMS ±10%	MAX. %	FREQ Hz	AC mA RMS	DC mA
	125	380	210	98	5	800	1.4	0.0

	0.0. "	Impromontanton baro	WEEELOE EELEE		ILE FIOTON
С	C10108156	10-10-08 1-17-08 Active			^
В	C10106978				(
А	C10103604	2 - 20 - 06			
WHEN TEST L	DR. BY	DATE			
CRITERIA, CORRELATION OF TEST EQUIPMENT WITH KNOWLES IS ALSO REQUIRED FOR ELIMINATION OF EQUIPMENT AND TEST METHOD VARIATION					2-19-06
	CK. BY	DATE			
TITLE:	RF	CFIVFR	EJ-23080-000	GJP	2-20-06
	11 _		20000 000	APP BY	DATE

SHT 2.1

2-20-06

PERFORMANCE SPECIFICATION

KNOWLES ELECTRONICS ITASCA, ILLINOIS U.S.A.